

**Notice of References Cited**

Application/Control No.

09/936,381

Applicant(s)/Patent Under  
Reexamination  
KAWALLA ET AL.

Examiner

Deborah Yee

Art Unit

1742

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	357002840A	01-1982	Japan	Furukawa, Takashi et al	148/602
	O					
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